

<b>Notice of References Cited</b>	Application/Control No. 10/712,788	Applicant(s)/Patent Under Reexamination DELMULLE ET AL.	
	Examiner Yuwen Pan	Art Unit 2618	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0064693	04-2004	Pabla et al.	713/168
*	B	US-6,970,548	11-2005	Pines et al.	379/218.01
	C	US-			
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

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